Notice of References Cited Application/Control No. 10/507,066 Examiner Benny Lee Applicant(s)/Patent Under Reexamination YE, SHEN Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,055,809	10-1991	Sagawa et al.	333/219
*	В	US-6,897,745	05-2005	Aiga et al.	333/204
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-	4		
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	05299914	11-1993	EPO	Setsune et al	
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U		
	V		
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	x		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.